Se	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/659,591	PAIK ET AL.	
Examiner	Art Unit	
M. Lee	2622	

SEARCHED			
Class	Subclass	Date	Examiner
348	678, 725, 726, 735,	7/3/2007	ML
375	345		,
455	234.1		
	234.2		
	239.1		
	240.1		
	241.1		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	ce search printout	7/3/2007	ML

SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
EAST	7/3/2007	ML
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